

# MOS FIELD EFFECT TRANSISTOR $\mu$ PA2794AGR

# SWITCHING N- AND P-CHANNEL POWER MOS FET

### **DESCRIPTION**

The  $\mu$ PA2794AGR is N- and P-channel MOS Field Effect Transistors designed for Motor Drive application.

### **FEATURES**

• Low on-state resistance

N-channel RDS(on)1 = 25 m $\Omega$  MAX. (VGS = 10 V, ID = 2.8 A)

 $R_{DS(on)2} = 33 \text{ m}\Omega \text{ MAX}. \text{ (V}_{GS} = 4.5 \text{ V}, I_{D} = 2.8 \text{ A})$ 

P-channel R<sub>DS(on)1</sub> = 43 m $\Omega$  MAX. (V<sub>GS</sub> = -10 V, I<sub>D</sub> = -2.8 A)

 $R_{DS(on)2} = 54 \text{ m}\Omega \text{ MAX}. \text{ (Vgs} = -4.5 \text{ V, I}_D = -2.8 \text{ A)}$ 

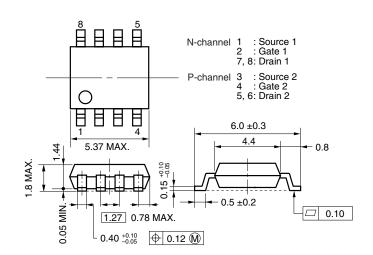
· Low input capacitance

N-channel C<sub>iss</sub> = 2200 pF TYP.

P-channel Ciss = 2200 pF TYP.

- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

# PACKAGE DRAWING (Unit: mm)

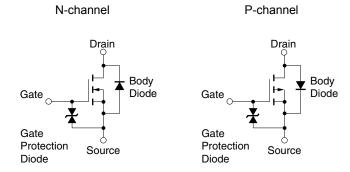


### ORDERING INFORMATION

| PART NUMBER                      | LEAD PLATING | PACKING          | PACKAGE    |  |
|----------------------------------|--------------|------------------|------------|--|
| μPA2794AGR-E1-AT <sup>Note</sup> |              |                  |            |  |
| μPA2794AGR-E2-AT Note            | Pure Sn      | Tape 2500 p/reel | Power SOP8 |  |

Note Pb-free (This product does not contain Pb in external electrode and other parts.)

### **EQUIVALENT CIRCUITS**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.

Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.

# **ABSOLUTE MAXIMUM RATINGS (TA = 25°C. All terminals are connected.)**

| PARAMETER                                       | SYMBOL                | N-CHANNEL   | P-CHANNEL | UNIT |
|-------------------------------------------------|-----------------------|-------------|-----------|------|
| Drain to Source Voltage (V <sub>GS</sub> = 0 V) | VDSS                  | 60          | -60       | V    |
| Gate to Source Voltage (VDS = 0 V)              | V <sub>GSS</sub>      | ±20         | ∓20       | V    |
| Drain Current (DC)                              | I <sub>D(DC)</sub>    | ±5.5        | ∓5.5      | Α    |
| Drain Current (pulse) Note1                     | I <sub>D(pulse)</sub> | ±22         | ∓22       | А    |
| Total Power Dissipation (1 unit) Note2          | P <sub>T1</sub>       | 1.7         |           | W    |
| Total Power Dissipation (2 units) Note2         | P <sub>T2</sub>       | 2.0         |           | W    |
| Channel Temperature                             | Tch                   | 150         |           | °C   |
| Storage Temperature                             | Tstg                  | -55 to +150 |           | °C   |
| Single Avalanche Current Note3                  | las                   | 5.5         | -5.5      | А    |
| Single Avalanche Energy Note3                   | Eas                   | 3.03        |           | mJ   |

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

- 2. Mounted on ceramic substrate of 2000 mm<sup>2</sup> x 1.6 mm
- 3. Starting Tch = 25°C, V<sub>DD</sub> = 30 V, R<sub>G</sub> = 25  $\Omega$ , L = 100  $\mu$ H, V<sub>GS</sub> = 20  $\rightarrow$  0 V

2



# **ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)**

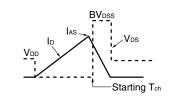
# N-channel

| SYMBOL               | TEST CONDITIONS                                 | MIN. | TYP. | MAX.                                                 | UNIT                                                 |
|----------------------|-------------------------------------------------|------|------|------------------------------------------------------|------------------------------------------------------|
| IDSS                 | V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V   |      |      | 10                                                   | μΑ                                                   |
| Igss                 | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V  |      |      | ±10                                                  | μΑ                                                   |
| V <sub>GS(off)</sub> | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA   | 1.5  | 2.0  | 2.5                                                  | V                                                    |
| y <sub>fs</sub>      | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2.8 A  | 4    | 7.6  |                                                      | S                                                    |
| R <sub>DS(on)1</sub> | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.8 A  |      | 19.5 | 25                                                   | mΩ                                                   |
| R <sub>DS(on)2</sub> | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 2.8 A |      | 23   | 33                                                   | mΩ                                                   |
| Ciss                 | V <sub>DS</sub> = 10 V,                         |      | 2200 |                                                      | pF                                                   |
| Coss                 | V <sub>GS</sub> = 0 V,                          |      | 245  |                                                      | pF                                                   |
| Crss                 | f = 1 MHz                                       |      | 136  |                                                      | pF                                                   |
| t <sub>d(on)</sub>   | V <sub>DD</sub> = 30 V, I <sub>D</sub> = 2.8 A, |      | 10   |                                                      | ns                                                   |
| tr                   | V <sub>GS</sub> = 10 V,                         |      | 16   |                                                      | ns                                                   |
| td(off)              | R <sub>G</sub> = 0 Ω                            |      | 58   |                                                      | ns                                                   |
| tr                   |                                                 |      | 7.5  |                                                      | ns                                                   |
| Q <sub>G</sub>       | I <sub>D</sub> = 5.5 A,                         |      | 41   |                                                      | nC                                                   |
| Q <sub>GS</sub>      | V <sub>DD</sub> = 48 V,                         |      | 6.3  |                                                      | nC                                                   |
| Q <sub>GD</sub>      | V <sub>GS</sub> = 10 V                          |      | 11   |                                                      | nC                                                   |
| V <sub>F(S-D)</sub>  | I <sub>F</sub> = 5.5 A, V <sub>GS</sub> = 0 V   |      | 0.8  | 1.5                                                  | V                                                    |
| trr                  | I <sub>F</sub> = 5.5 A, V <sub>GS</sub> = 0 V,  |      | 28   |                                                      | ns                                                   |
| Qrr                  | di/dt = 100 A/μs                                |      | 29   |                                                      | nC                                                   |
|                      | IDSS                                            | IDSS | IDSS | $\begin{array}{llllllllllllllllllllllllllllllllllll$ | $\begin{array}{llllllllllllllllllllllllllllllllllll$ |

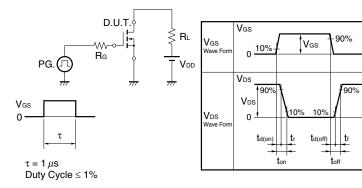
Note Pulsed

# **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \ \Omega \\ \text{V} \\ \text{VGS} = 20 \rightarrow 0 \ \text{V} \end{array}$



# **TEST CIRCUIT 2 SWITCHING TIME**



# **TEST CIRCUIT 3 GATE CHARGE**

90%

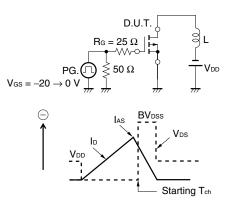


# P-channel

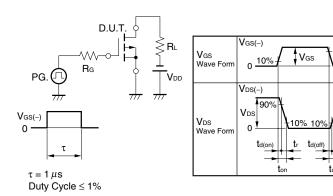
| CHARACTERISTICS                          | SYMBOL               | TEST CONDITIONS                                   | MIN. | TYP. | MAX. | UNIT |
|------------------------------------------|----------------------|---------------------------------------------------|------|------|------|------|
| Zero Gate Voltage Drain Current          | IDSS                 | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V    |      |      | -10  | μΑ   |
| Gate Leakage Current                     | Igss                 | V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V    |      |      | ∓10  | μΑ   |
| Gate to Source Cut-off Voltage           | V <sub>GS(off)</sub> | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA   | -1.0 | -1.7 | -2.5 | V    |
| Forward Transfer Admittance Note         | y <sub>fs</sub>      | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -2.8 A  | 5    | 10   |      | S    |
| Drain to Source On-state Resistance Note | R <sub>DS(on)1</sub> | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -2.8 A  |      | 33   | 43   | mΩ   |
|                                          | R <sub>DS(on)2</sub> | V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -2.8 A |      | 36   | 54   | mΩ   |
| Input Capacitance                        | Ciss                 | V <sub>DS</sub> = -10 V,                          |      | 2200 |      | pF   |
| Output Capacitance                       | Coss                 | V <sub>GS</sub> = 0 V,                            |      | 270  |      | pF   |
| Reverse Transfer Capacitance             | Crss                 | f = 1 MHz                                         |      | 200  |      | pF   |
| Turn-on Delay Time                       | t <sub>d(on)</sub>   | V <sub>DD</sub> = -30 V, I <sub>D</sub> = -2.8 A, |      | 10   |      | ns   |
| Rise Time                                | tr                   | V <sub>GS</sub> = -10 V,                          |      | 22   |      | ns   |
| Turn-off Delay Time                      | td(off)              | R <sub>G</sub> = 0 Ω                              |      | 150  |      | ns   |
| Fall Time                                | tr                   |                                                   |      | 23   |      | ns   |
| Total Gate Charge                        | Q <sub>G</sub>       | I <sub>D</sub> = -5.5 A,                          |      | 45   |      | nC   |
| Gate to Source Charge                    | Qgs                  | V <sub>DD</sub> = -48 V,                          |      | 4.3  |      | nC   |
| Gate to Drain Charge                     | Q <sub>GD</sub>      | V <sub>GS</sub> = -10 V                           |      | 13   |      | nC   |
| Body Diode Forward Voltage Note          | V <sub>F(S-D)</sub>  | I <sub>F</sub> = 5.5 A, V <sub>GS</sub> = 0 V     |      | 0.83 | 1.5  | V    |
| Reverse Recovery Time                    | trr                  | I <sub>F</sub> = -5.5 A, V <sub>GS</sub> = 0 V,   |      | 46   |      | ns   |
| Reverse Recovery Charge                  | Qrr                  | di/dt = -50 A/μs                                  |      | 29   |      | nC   |

Note Pulsed

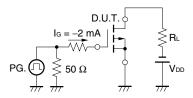
# **TEST CIRCUIT 1 AVALANCHE CAPABILITY**



# **TEST CIRCUIT 2 SWITCHING TIME**

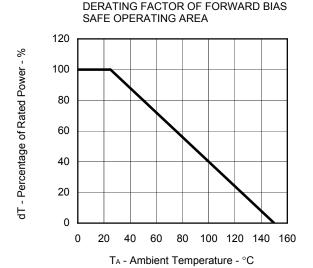


# **TEST CIRCUIT 3 GATE CHARGE**

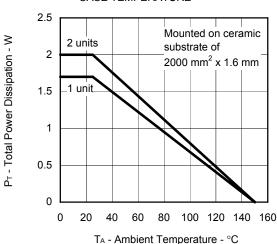


# TYPICAL CHARACTERISTICS (TA = 25°C)

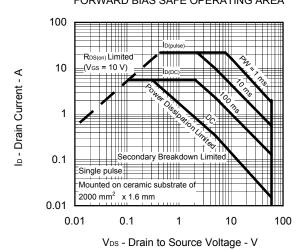
# (1) N-channel



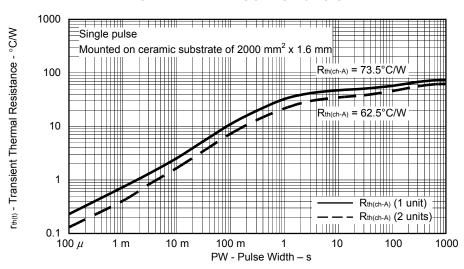
# TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



# FORWARD BIAS SAFE OPERATING AREA



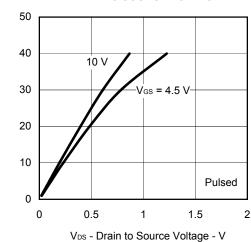
### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



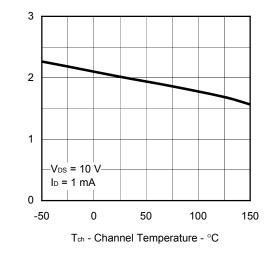
Ip - Drain Current - A

Ves(off) - Gate to Source Cut-off Voltage - V

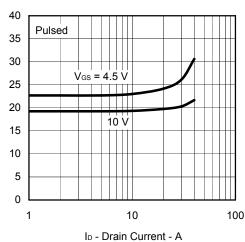
# DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



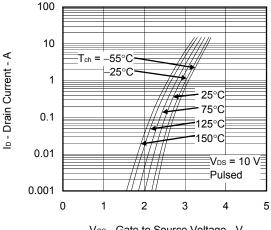
# GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



# DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

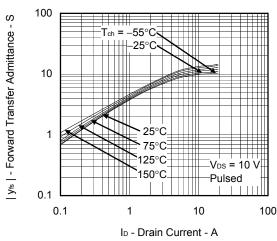


### FORWARD TRANSFER CHARACTERISTICS

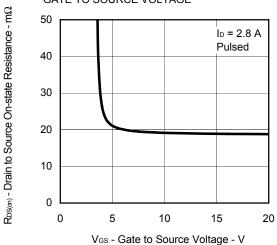


# V<sub>GS</sub> - Gate to Source Voltage - V

# FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



# DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



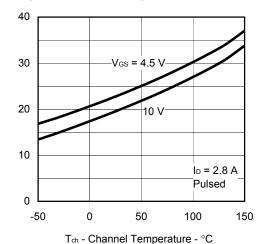
6

 $\mathsf{R}_{\mathsf{DS}(m)}$  - Drain to Source On-state Resistance -  $m\Omega$ 

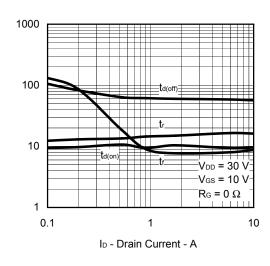
 $\mathsf{Ro}_{\mathsf{S}(m)}$  - Drain to Source On-state Resistance -  $m\Omega$ 

ta(on), tr, ta(off), tr - Switching Time - ns

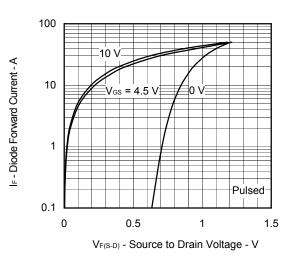
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



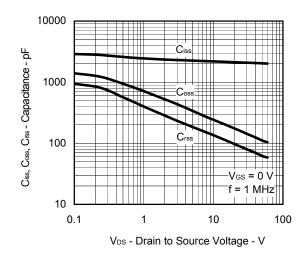
# SWITCHING CHARACTERISTICS



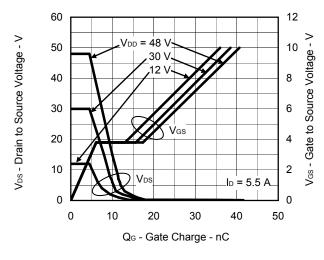
# SOURCE TO DRAIN DIODE FORWARD VOLTAGE



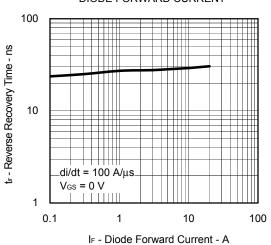
### CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



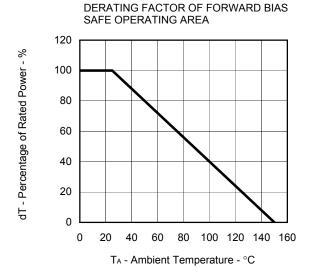
# DYNAMIC INPUT/OUTPUT CHARACTERISTICS



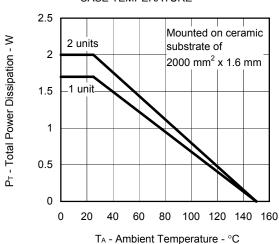
# REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



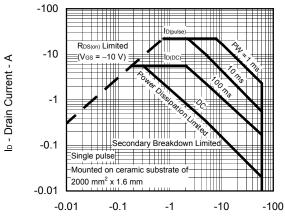
# (2) P-channel



# TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

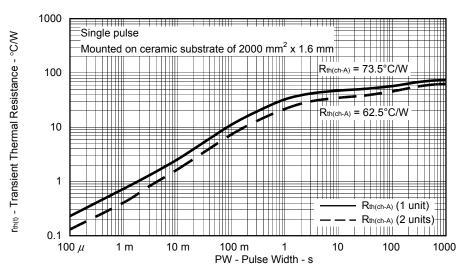


### FORWARD BIAS SAFE OPERATING AREA



VDS - Drain to Source Voltage - V

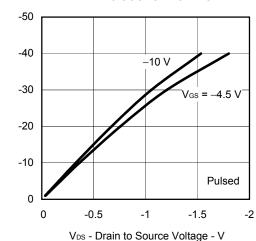
### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



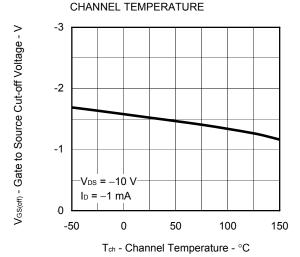
Ip - Drain Current - A

R<sub>DS(on)</sub> - Drain to Source On-state Resistance - mΩ

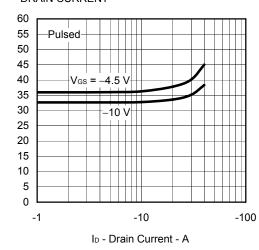
# DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



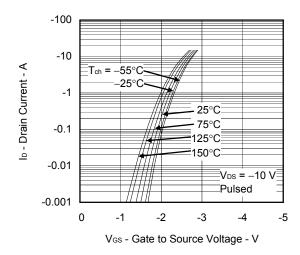
# GATE TO SOURCE CUT-OFF VOLTAGE vs.



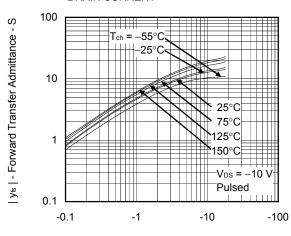
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



### FORWARD TRANSFER CHARACTERISTICS

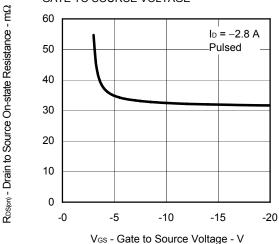


# FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



ID - Drain Current - A

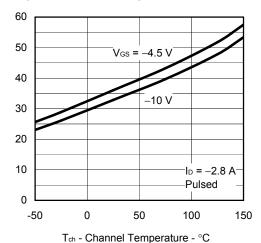
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



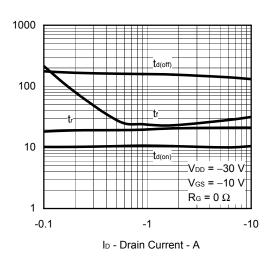
 $R_{DS(m)}$  - Drain to Source On-state Resistance -  $m\Omega$ 

ta(on), tr, ta(off), tr - Switching Time - ns

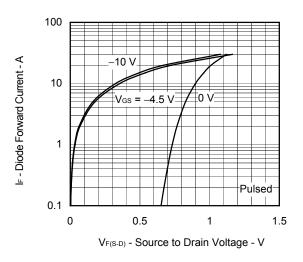
# DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



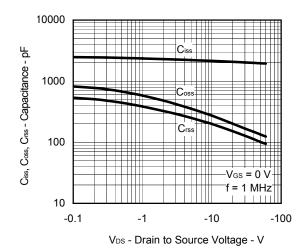
# SWITCHING CHARACTERISTICS



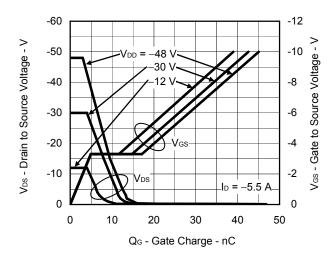
### SOURCE TO DRAIN DIODE FORWARD VOLTAGE



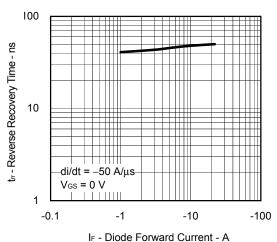
### CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



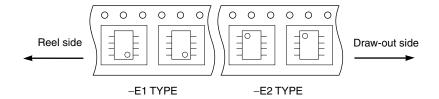
# REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



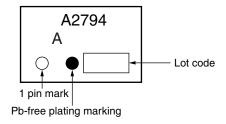


### TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



# **MARKING INFORMATION**



# RECOMMENDED SOLDERING CONDITIONS

The  $\mu$ PA2794AGR should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

| Soldering Method | Soldering Conditions                                                   | Recommended Condition Symbol |
|------------------|------------------------------------------------------------------------|------------------------------|
| Infrared reflow  | Maximum temperature (Package's surface temperature): 260°C or below    | IR60-00-3                    |
|                  | Time at maximum temperature: 10 seconds or less                        |                              |
|                  | Time of temperature higher than 220°C: 60 seconds or less              |                              |
|                  | Preheating time at 160 to 180°C: 60 to 120 seconds                     |                              |
|                  | Maximum number of reflow processes: 3 times                            |                              |
|                  | Maximum chlorine content of rosin flux (percentage mass): 0.2% or less |                              |
| Partial heating  | Maximum temperature (Pin temperature): 350°C or below                  | P350                         |
|                  | Time (per side of the device): 3 seconds or less                       |                              |
|                  | Maximum chlorine content of rosin flux: 0.2% (wt.) or less             |                              |

Caution Do not use different soldering methods together (except for partial heating).

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- "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.
- "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).
- "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.

### (Note)

- (1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).